

IN THE UNITED S PATENT AND TRADEMARK OFFICE

Applicant: Wallace T.Y. Tang

Art Unit

: 1763

Serial No.: 09/134,147

Examiner: Trung Dang

Filed Title

: August 14, 1998

: IN-SITU REAL-TIME MONITORING TECHNIQUE AND APPARATUS FOR

DETECTION OF THIN FILMS DURING CHEMICAL/MECHANICAL

POLISHING PLANARIZATION

Commissioner for Patents Washington, D.C. 20231

PETITION FOR THREE-MONTH EXTENSION OF TIME

Pursuant to 37 CFR §1.136, applicant hereby petitions that the period for response to the action dated May 22, 2000, be extended for three months to and including November 22, 2000.

Enclosed is a check for \$890 for the required fee. Please apply any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date:	1	121	100	

Reg. No. 34,609

Correspondence Address:

Patent Counsel Applied Materials, Inc. Legal Affairs Department P.O. Box 450A Santa Clara, CA 95052 50030807.doc

12/01/2000 HNOOR1 00000062 09134147

01 FC:117

890.00 OP

CERTIFICATE OF MAILING BY FIRST CLASS MAIL

ECHNOLOGY CENTER 1700

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, Washington, D.C. 20231.

November 21, 2000
Date of Deposit
Marildy
Signature

Matilde C. Sanchez

Typed or Printed Name of Person Signing Certificate